

Construction of a sense of force feedback and vision for micro-objects

R.Uehara

*Graduate School of Computer Science
and System Engineering
Kyushu Institute of Technology
680-4, Iizuka City, Fukuoka, Japan, 820-8502
uehara@mmcs.mse.kyutech.ac.jp*

E.Hayashi

*Department of Mechanical Information
Science and Technology
Kyushu Institute of Technology
680-4, Iizuka City, Fukuoka, Japan, 820-8502
haya@mse.kyutech.ac.jp*

Abstract. The purpose of this research was to develop a combined sense system that uses both force feedback and visual feedback to determine the shape of the microscopic features of a microsample. It is thought that the efficiency of minute procedures would be improved if the operator were able to have a sense of force while using a manipulator. We used a cantilever to touch a minute object and obtain a reaction force from the degree of bending. We constructed a haptic device that gives a sense of that force to the operator, who can feel the force when a user touches the sample with a cantilever. In addition, when the haptic device is used in simulations, the user can feel a force as if he had touched the sample.

Key words: force feedback, haptic interface, simulation.

1. Introduction

Technologies that can accurately perform minute work are now being sought for both medical treatment and in the field of manufacturing semiconductors. Such minute work is improved by using micromanipulators, but their operation is difficult because the operator has no sense of force; he relies only on sight through a microscope. As a result, a person skilled in the use of this technology is needed for all minute work. It is thought that the efficiency of minute work would be improved if the operator were able to have a sense of force while using a manipulator.

This study describes the development of a more efficient system for minute operations. Our aim was to develop a system using not only the sense of sight through a microscope, but also a sense of force from the manipulator. For this fundamental research, a system was created to assess the reaction force when a minute sample was touched. A cantilever was used to touch the sample, and the reaction force was obtained from the degree to which the sample bent. In addition, we used a haptic device and amplified the force feedback from a minute sample of a virtual object.

2. System Structure

2-1. System Summary

The structure of the system is shown in Fig. 1a, and a schematic view is shown in Fig. 1b. This system consists of a microscope with an automatic x-y stage, a piezo stage, a feedback stage controller to control the x-y stage, a piezo stage controller, a haptic device for transmitting

force feedback (Fig. 2), a cantilever (Fig. 3), and a PC via which the user can control and operate these components. The sample was fixed on the x-y stage by an injector (Fig. 4) and a holding pipette (Fig. 5). When the cantilever, which was fixed to the piezo stage, touched the sample, the operator could feel a force as if he had touched the sample using the haptic device. The resolution of the piezo stage is 1 nm. Table 1 gives the specifications of the injector, and Table 2 gives the specifications of the holding pipette.

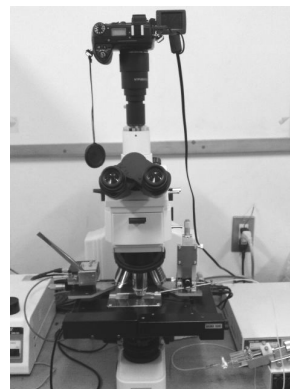


Fig. 1a. Photograph of the structure of the system.

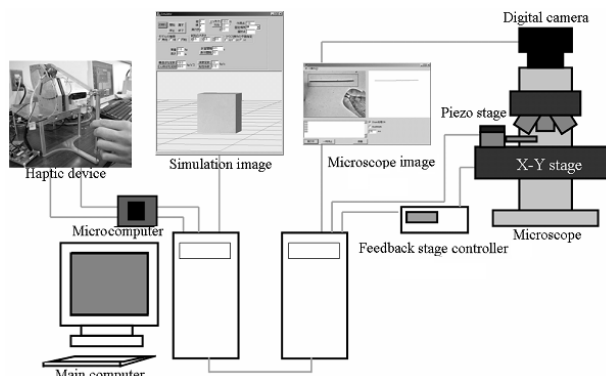


Fig. 1b. A schematic view of the system's structure.

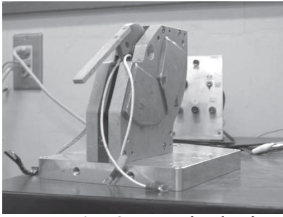


Fig. 2. Haptic device.

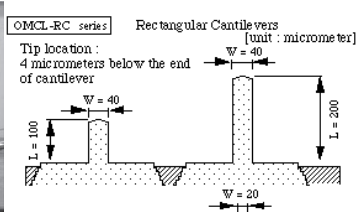


Fig. 3. Cantilever.



Fig. 4. Injector.

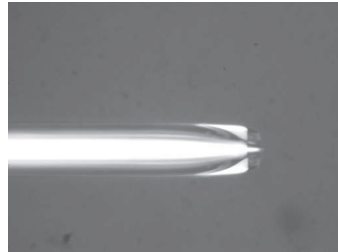


Fig. 5. Tip of holding pipette.

Table 1. Specifics of the injector.

Drive distance	40 mm
Braking distance	800 μ
Size	200 \times 80 \times 30 mm
Weight	2 kg

Table 2. Specifics of the holding pipette.

Length	60 mm
Inside diameter	13 μ m

2-2. Haptic device

Figure 6 is a diagram of the haptic device. It consists primarily of a rotor, a laser, and a position-sensitive device (PSD). We installed a coil on the rotor with a polarity magnet, which generated electromagnetic induction by an electric current and a magnetic force. The angle of the rotor can be measured by the laser and the PSD. The rotor was able to follow any input waveform.

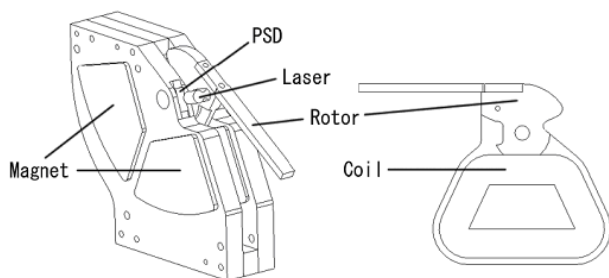


Fig. 6. Diagram of the haptic device.

It was necessary to control the actuator with a

servomechanism on the actuator. Therefore, the system driving the actuator consisted of four actuators: a microcomputer, an inputting AD/DA port, an outputting microcomputer, and a PC outputting order value. The system controls the actuator during each part of the process. Figure 7 shows the structure of the haptic device.

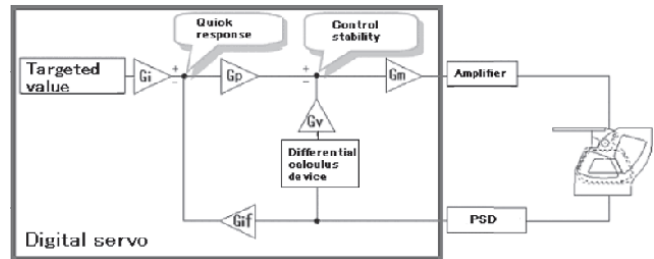


Fig. 7. Structure of the haptic device.

The actuator, which is structured by the PD control, is operated through a digital differential calculus device. A transfer function for the quadratic function system shown in Fig. 8 is provided for the actuator servo system. The role of each parameter of the control system is to adjust the total offset to a master in G_i/G_{if} , to regulate the item viscosity/resonance point in G_p/G_v , and to regulate the total gain in G_m . Table 3 is a list of the control parameters of the servomechanism system.

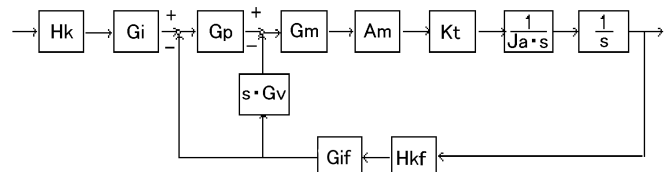


Fig. 8. Block diagram of the servomechanism system.

Table 3 Control parameters of the servomechanism system

Parameter	Reference	Unit
G_i	Controller Input Gain	1.0
G_{if}	Position Feedback Gain	1.0
G_p	Position Gain	1.0
G_v	Velocity Gain	0.0015
G_m	Manipulation Gain	1.0
H_k	Position Voltage Constant	18.531 V/rad
H_{kf}	Position Voltage Feedback Constant	18.531 V/rad
A_m	Amplifier Constant	1.0 A/V
K_t	Torque Constant	2.768 Nm/A
J_a	Moment of Inertia	0.0002147 kg \cdot m ²

3. Measuring the antipower

The reaction force is used to calculate the force that is applied by the minute object. In this experiment, we touched the minute object with the cantilever shown in Fig. 3, and the reaction force was obtained from the degree of bend of the cantilever. The layout of the experiment is shown in Figs. 7

and 8, and the environment of the experiment is shown in Figs. 9 and 10. As a result of this experiment, we obtained the reaction force applied by the minute object.

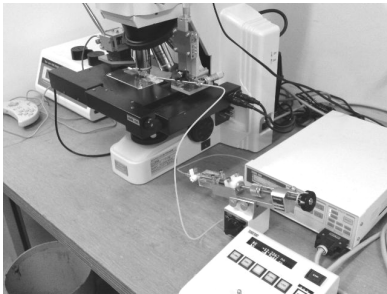


Fig. 9. Environment of the experiment.

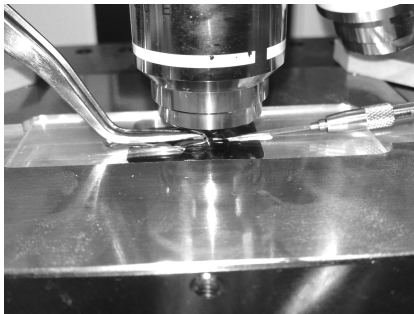


Fig. 10. Environment of the experiment.

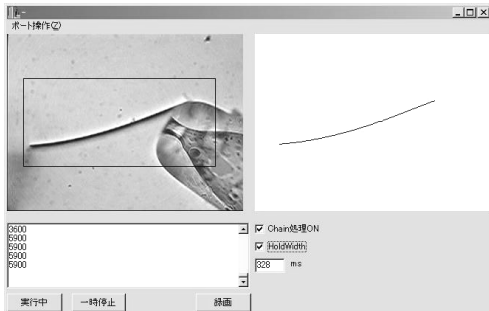


Fig. 11. Cantilever touching the tip of the holding pipette.

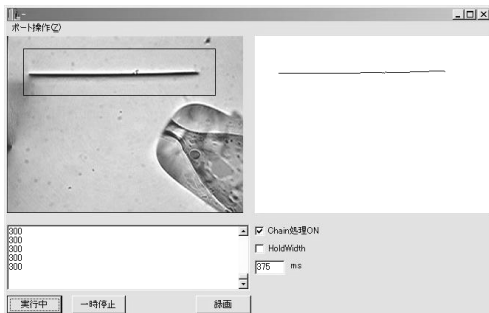


Fig. 12. The cantilever detection program.

Figure 11 shows the cantilever touching the tip of the holding pipette. The image processing speed of the cantilever was improved by the tracking process (Fig. 12). The bend of the cantilever is assumed to be linear-elastic so that Hooke's law may be applied. Then the restoring force F of the bend of the cantilever is given by

$$F = kx \quad (1)$$

where x is the compression distance from the equilibrium position, and k is the spring constant.

4. Deforming the simulation of the sample

In this study, we aimed to build a working system using a microscope, a haptic device and a simulation. A fundamental element was the simulation of the deformation of a minute object. Figure 13 shows the graphical user interface (GUI) of the simulator. A graphic tool is created using OpenGL to draw the object and to choose the shape of the sample, for instance, a cube or sphere. A dynamic model of the sample consists of a spring-mass array of mass points in both the vertical and horizontal directions. An example of the arrangement of mass points is shown in Fig. 14. When a force was applied at a mass point, the simulation calculated the speed of all mass points that had been affected. The image is renewed after every ten calculations.

A spring is defined as having a size but no weight, and a mass point is defined as having a size, a weight and a rigid body. An arbitrary mass object can be placed on a spring on a bitmap (Fig. 15). In addition, a sample can be seen from various viewpoints, and the deformation of the sample, which is impossible to observe by microscope, can be checked. The shape of this object can be either a cube or a sphere, and any point may be selected as a fixed point or an operating point.

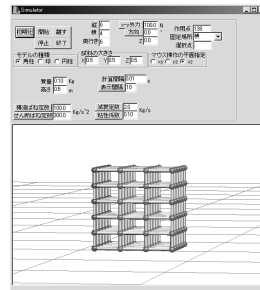


Fig. 13. Simulator.

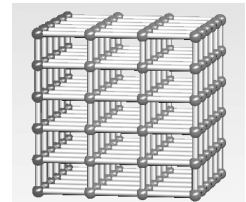


Fig. 14. Arrangement of mass points

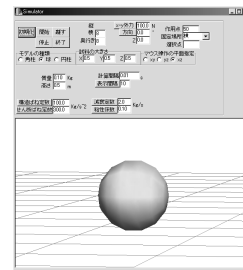


Fig. 15. Placing an arbitrary object on a bitmap.

The calculation method for the displacement of each mass point is based on Newton's equation of motion (Eq. 1) using the Euler method. A mass point is linked to an adjacent mass

point at both ends of a spring. When the spring between the mass points is in the equilibrium position, the restoring force F is the sum of the elastic force of the construction spring and the shear spring, and the viscous force is given by

$$ma = \sum F \quad (2)$$

where m is mass and a is acceleration.

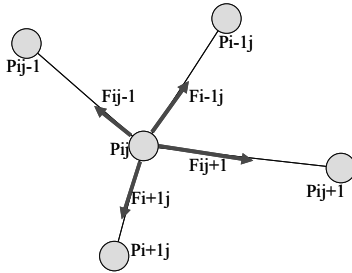


Fig. 16. Elasticity.

$\sum F$ is sum of the elastic force of the construction spring and shear spring, the viscous force and the damping force. To obtain the restoring force F , the restoring force was divided into $F_{damping}$, F_{spring} and $F_{viscous}$. Equation 2 gives the following equations using the model shown in Fig. 16.

$$F_{spring} = \sum F_{ij} \quad (3)$$

$$F_{damping} = -C_d v_i \quad (4)$$

$$F_{viscous} = -C_v (v_i - v_j) \quad (5)$$

$$\sum F = F_{spring} + F_{damping} + F_{viscous} \quad (6)$$

where C_d is the damping factor, C_v is viscosity, and v_i and v_j are the velocities.

5. Conclusion

The present study evaluated whether the force feedback is amplified by touching a virtual object with a haptic device in a PC. We found that it is possible to amplify the reaction force, but were unable to create a large enough reaction force for a worker to feel its elasticity.

Future research should focus on building a system that allows a reaction force to be detected and shown more precisely. Such a system would make it possible to test smaller samples.

6. Acknowledgement

This research was supported in part by a Grant-in-Aid for Scientific Research, 2009 from the Ministry of Education, Science, Sports and Culture.

References

1. Li X, Zhang Z (2008) Probe-type microforce sensor for micro/nano experimental mechanics. Trans Tech Publications, Stafa-Zurich, Switzerland
2. Zhang J, Xi N, Li G, et al. (2006) Atomic force microscopy sensing using multiple modes. 2006 IEEE/RSJ International Conference on Intelligent Robots and Systems, Beijing, China, 9-15 October. IEEE, Piscataway, NJ
3. Hrouzek M (2005) Feedback control in an atomic force microscope used as a nano-manipulator. Acta Polytech Czech Tech Univ Prague 45(4):65-69
4. Ujihara R (2004) Developing the haptic device. Kyushu Institute of Technology
5. Yaacoub F, Hamam Y, Abche A (2008) Computer-based training system for simulating wrist arthroscopy. Université Paris-Est, ESIEE, Laboratoire A²SI, Cité Descartes, 93162 Noisy Le Grand, France. University of Balamand, Department of Electrical Engineering, P.O.Box 100, Tripoli Lebanon F'Satie – TUT, Private Bag X680, Pretoria 0001, South Africa. Proceedings of the 21st IEEE International Symposium on Computer-Based Medical Systems (CBMS 2008)
6. Tahmasebi AM, Taati B, Mobasser F, et al. (2005) Dynamic parameter identification and analysis of a PHANToM trade haptic device. School of Computing, Queen's University, Kingston, ON, Canada. Department of Electrical and Computer Engineering, Queen's University, Kingston, ON, Canada. 2005 IEEE International Conference on Control Applications (CCA) (IEEE Cat. No. 05CH37713)
7. Sonoda T (2006) Construction of super-micro sense of force feedback and visual for an elastic body. Kyushu Institute of Technology. Proceedings of the 12th International Symposium on Artificial Life and Robotics, Beppu, Oita, Japan, 2006
8. Miyamoto K (2007) Construction of super-micro sense of force feedback and visual for micro objects. Kyushu Institute of Technology. Proceedings of the 12th International Symposium on Artificial Life and Robotics, Beppu, Oita, Japan, 2007